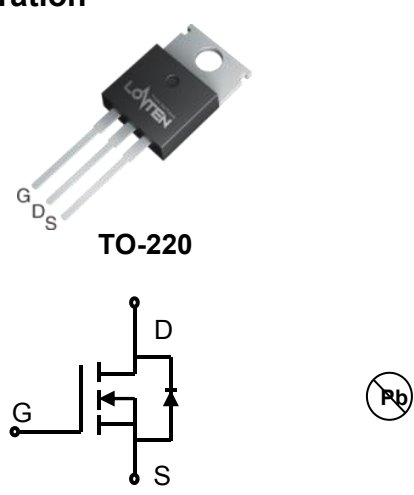


## Lonten N-channel 100V, 75A, 8mΩ Power MOSFET

<b>Description</b> These N-Channel enhancement mode power field effect transistors are using <b>shielded gate trench</b> DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and with stand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.	<b>Product Summary</b> $V_{DS}$ 100V $R_{DS(on),max}@ V_{GS}=10V$ 8mΩ $I_D$ 75A
<b>Features</b> <ul style="list-style-type: none"> <li>◆ 100V, 75A, <math>R_{DS(on),max}=8m\Omega@V_{GS} = 10V</math></li> <li>◆ Improved dv/dt capability</li> <li>◆ Fast switching</li> <li>◆ 100% EAS Guaranteed</li> <li>◆ Green device available</li> </ul>	<b>Pin Configuration</b>  <p style="text-align: center;">TO-220</p> <p style="text-align: center;">N-Channel MOSFET</p>
<b>Applications</b> <ul style="list-style-type: none"> <li>◆ Motor Drives</li> <li>◆ UPS</li> <li>◆ DC-DC Converter</li> </ul>	

### Absolute Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Continuous drain current ( $T_C = 25^\circ C$ ) ( $T_C = 100^\circ C$ )	$I_D$	75 48	A A
Pulsed drain current <sup>1)</sup>	$I_{DM}$	300	A
Gate-Source voltage	$V_{GSS}$	$\pm 20$	V
Avalanche energy <sup>2)</sup>	$E_{AS}$	26.5	mJ
Power Dissipation	$P_D$	89	W
Storage Temperature Range	$T_{STG}$	-55 to +150	$^\circ C$
Operating Junction Temperature Range	$T_J$	-55 to +150	$^\circ C$

### Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	1.4	$^\circ C/W$
Thermal Resistance, Junction-to-Ambient <sup>3)</sup>	$R_{\theta JA}$	70	$^\circ C/W$

### Package Marking and Ordering Information

Device	Device Package	Marking	Units/Tube
LSGC10R080WB	TO-220	C10R080WB	50

**Electrical Characteristics**
 $T_J = 25^{\circ}\text{C}$  unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static characteristics</b>						
Drain-source breakdown voltage	$BV_{DSS}$	$V_{GS}=0\text{ V}, I_D=250\mu\text{A}$	100	---	---	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.0	---	4.0	V
Drain-source leakage current	$I_{DSS}$	$V_{DS}=100\text{ V}, V_{GS}=0\text{ V}, T_J = 25^{\circ}\text{C}$	---	---	1	$\mu\text{A}$
		$V_{DS}=100\text{ V}, V_{GS}=0\text{ V}, T_J = 150^{\circ}\text{C}$	---	---	10	mA
Gate leakage current, Forward	$I_{GSSF}$	$V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$	---	---	100	nA
Gate leakage current, Reverse	$I_{GSSR}$	$V_{GS}=-20\text{ V}, V_{DS}=0\text{ V}$	---	---	-100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{ V}, I_D=40\text{ A}, T_J = 25^{\circ}\text{C}$	---	6.7	8	m $\Omega$
		$T_J = 150^{\circ}\text{C}$	---	13.2	---	m $\Omega$
Forward transconductance	$g_{fs}$	$V_{DS}=40\text{ V}, I_D=40\text{ A}$	---	92	---	S
<b>Dynamic characteristics</b>						
Input capacitance	$C_{iss}$	$V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V},$ $f = 250\text{ kHz}$	---	2890	---	pF
Output capacitance	$C_{oss}$		---	253	---	
Reverse transfer capacitance	$C_{rss}$		---	4.7	---	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 50\text{ V}, V_{GS}=10\text{ V}, I_D = 40\text{ A}$	---	28.5	---	ns
Rise time	$t_r$		---	93.4	---	
Turn-off delay time	$t_{d(off)}$		---	60.8	---	
Fall time	$t_f$		---	28	---	
Gate resistance	$R_g$	$V_{GS}=0\text{ V}, V_{DS}=0\text{ V}, f=1\text{ MHz}$	---	1	---	$\Omega$
<b>Gate charge characteristics</b>						
Gate to source charge	$Q_{gs}$	$V_{DS}=80\text{ V}, I_D=40\text{ A},$ $V_{GS}= 10\text{ V}$	---	13.3	---	nC
Gate to drain charge	$Q_{gd}$		---	17	---	
Gate charge total	$Q_g$		---	56.5	---	
Gate plateau voltage	$V_{plateau}$		---	4.5	---	V
Output Charge	$Q_{oss}$	$V_{DS}=80\text{ V}, V_{GS}= 0\text{ V}$	---	69	---	nC
<b>Drain-Source diode characteristics and Maximum Ratings</b>						
Continuous Source Current	$I_S$		---	---	75	A
Pulsed Source Current	$I_{SM}$		---	---	300	A
Diode Forward Voltage	$V_{SD}$	$V_{GS}=0\text{ V}, I_S=40\text{ A}, T_J=25^{\circ}\text{C}$	---	---	1.1	V
Reverse Recovery Time	$t_{rr}$	$I_S=40\text{ A}, di/dt=100\text{ A}/\mu\text{s},$ $T_J=25^{\circ}\text{C}$	---	41.3	---	ns
Reverse Recovery Charge	$Q_{rr}$		---	47	---	nC

**Notes:**

1: Repetitive Rating: Pulse width limited by maximum junction temperature.

2:  $V_{DD}=25\text{ V}, V_{GS}=10\text{ V}, L=0.1\text{ mH}, I_{AS}=23\text{ A},$  Starting  $T_J=25^{\circ}\text{C}$ .

3: The value of  $R_{thJA}$  is measured by placing the device in a still air box which is one cubic foot.

## Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

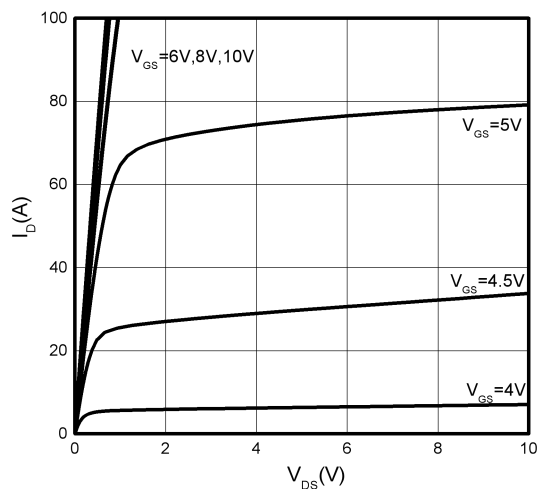


Figure 2. Transfer Characteristics

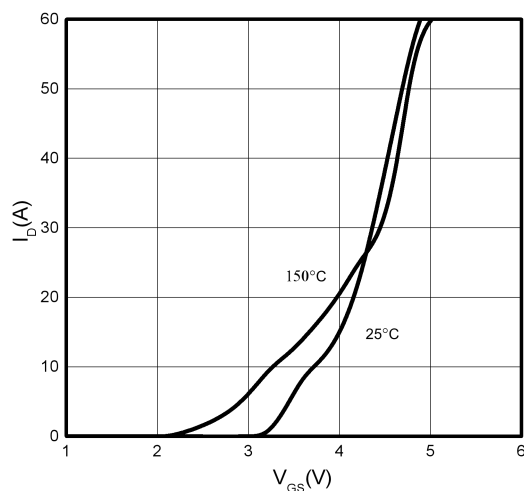


Figure 3. On-Resistance vs. Drain Current

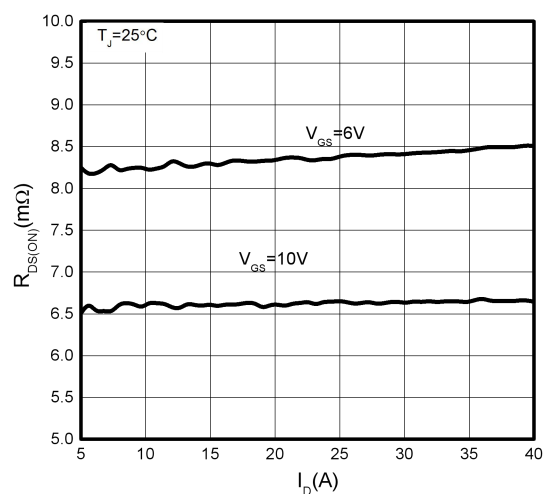


Figure 4. On-Resistance vs. Temperature

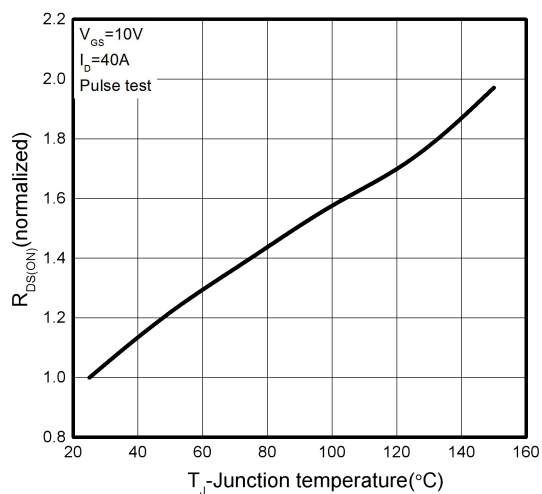


Figure 5. Breakdown Voltage vs. Temperature

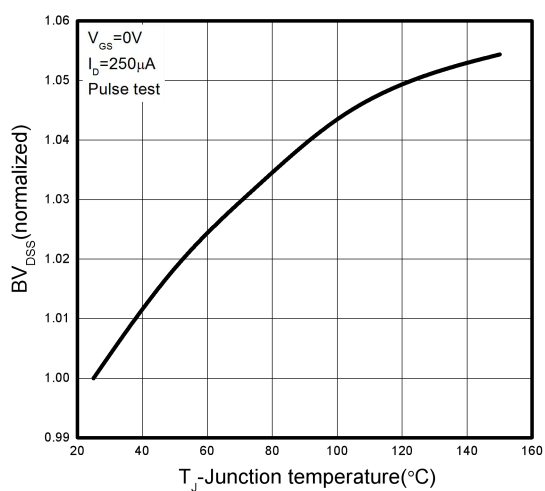


Figure 6. Threshold Voltage vs. Temperature

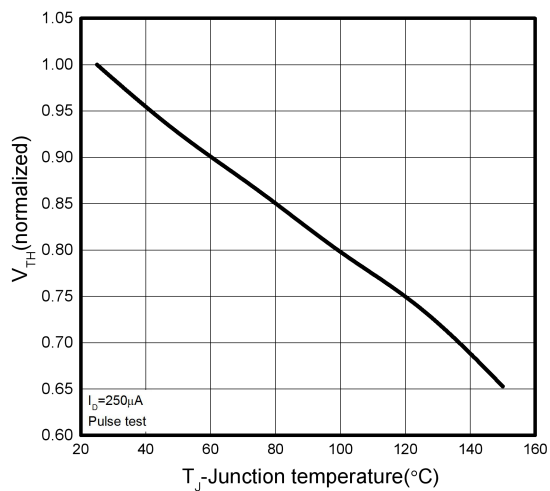


Figure 7.  $R_{DS(on)}$  vs. Gate Voltage

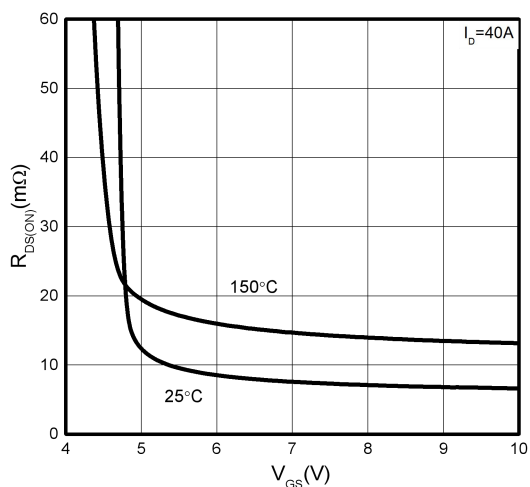


Figure 8. Body-Diode Characteristics

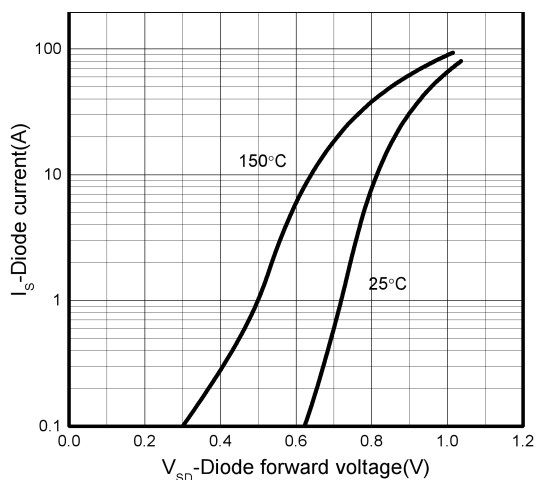


Figure 9. Capacitance Characteristics

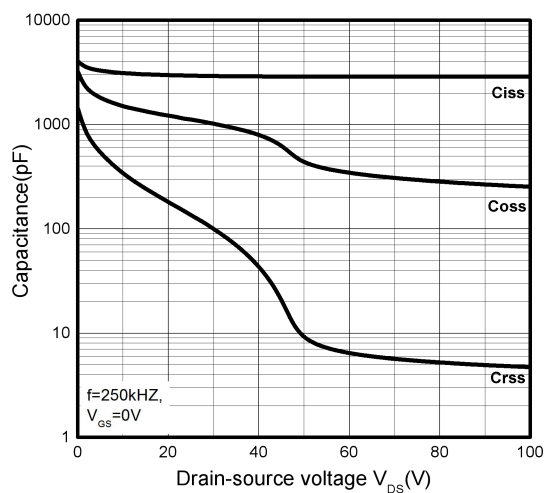


Figure 10. Gate Charge Characteristics

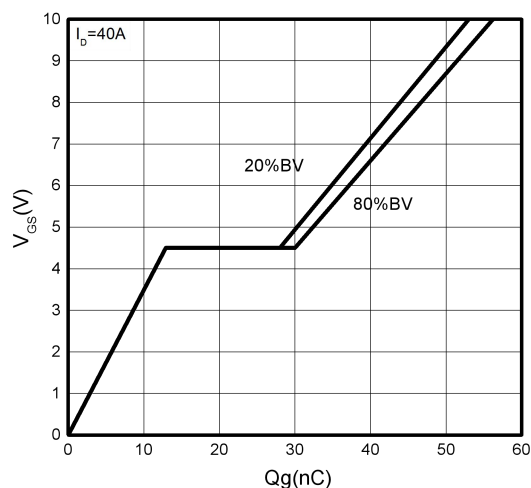


Figure 11. Drain Current Derating

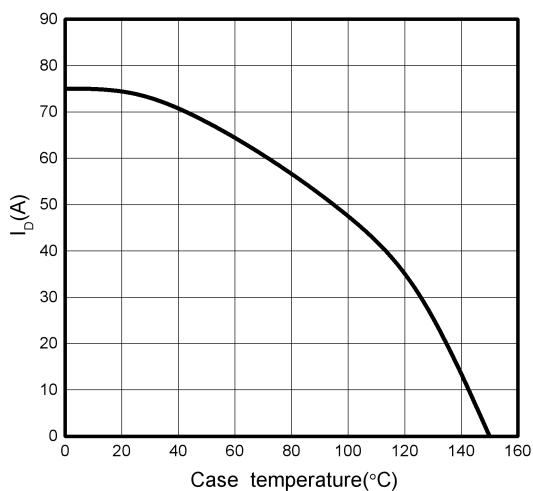


Figure 12. Power Dissipation vs. Temperature

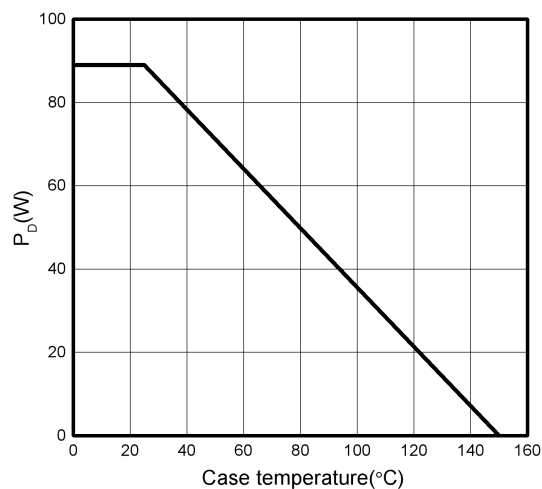


Figure 13: Safe Operating Area

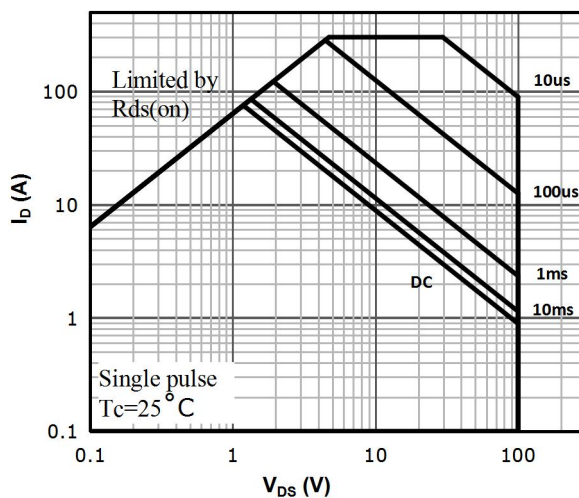
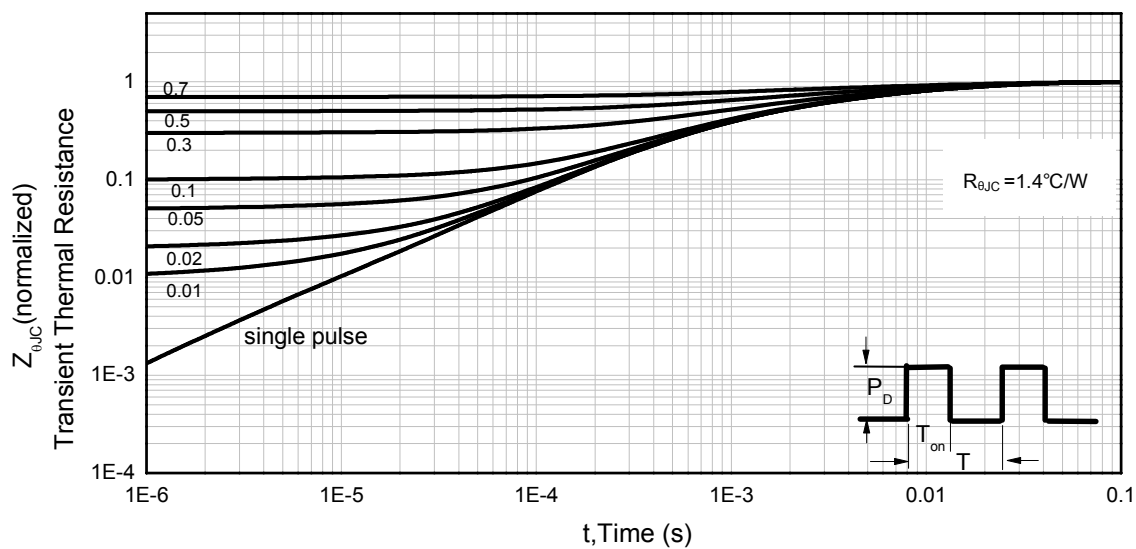
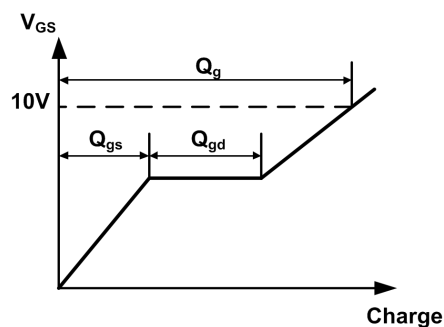
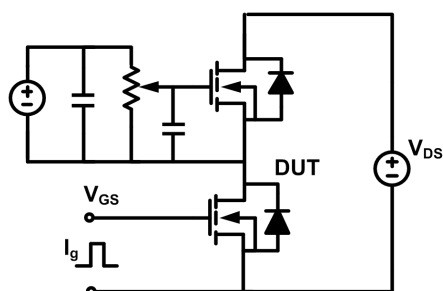


Figure 14. Normalized Maximum Transient Thermal Impedance ( $R_{thJC}$ )

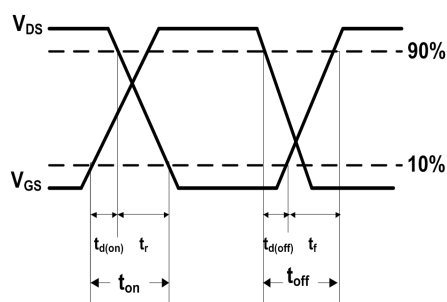
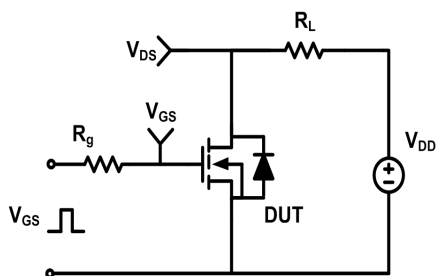


# Test Circuit & Waveforms

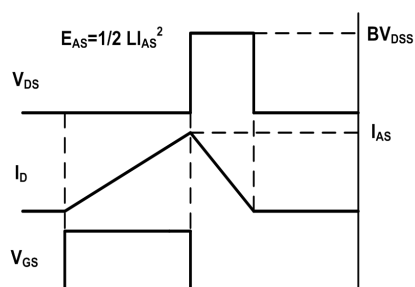
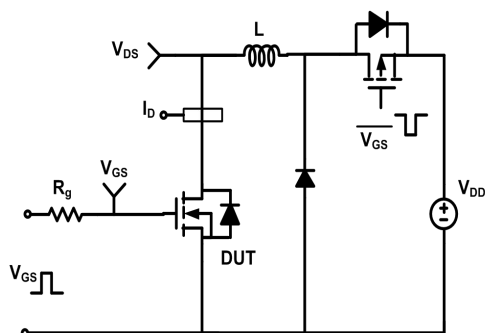
## Gate Charge Test Circuit & Waveform



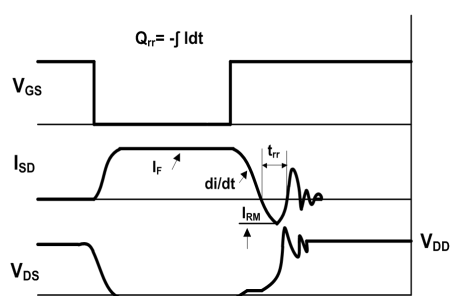
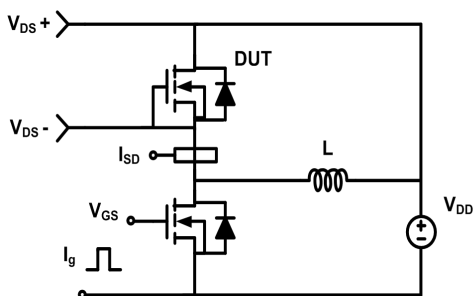
## Resistive Switching Test Circuit & Waveform



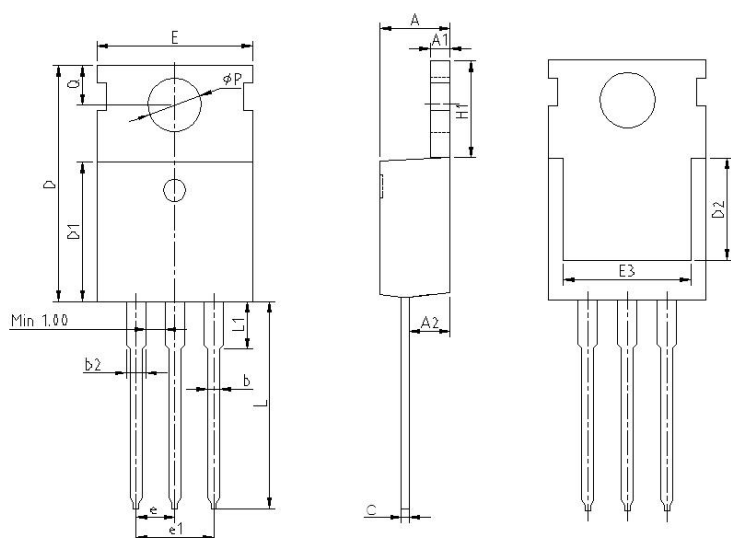
## Unclamped Inductive Switching (UIS) Test Circuit & Waveform



## Diode Recovery Test Circuit & Waveform



**Mechanical Dimensions for TO-220**



DIMENSIONS IN MILLITMETERS		
SYMBOL	MIN	MAX
A	4.25	4.7
A1	1.2	1.4
A2	2.2	2.92
b	0.7	0.97
b2	1.14	1.78
c	0.4	0.61
D	14.32	16.1
D1	8.39	9.4
D2	5.5	7
E	9.7	10.36
E3	7	8.78
e	2.54BSC	
e1	5.08BSC	
H1	6.25	6.85
L	12.75	14.4
L1	—	4.05
ΦP	3.4	3.8
Q	2.54	3

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**Version Information**

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LSGC10R080WB

**Revision:2021-08-11 ,Rev 1.0****Disclaimer**

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